

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/924,054	SAITO, HIROYUKI
Examiner	Art Unit	
John L. Shew	2664	

SEARCHED			
Class	Subclass	Date	Examiner
340	2.1,2.23	10/18/2005	JS
	2.24,3.1		
370	229,230.1	10/18/2005	JS
	232,233		
	235,237		
	238,238.1		
	252		
370	351	10/19/2005	JS
	389,395.1		
	395.21		
	395.32		
	395.41		
	400,468		
	477,537		

Search Notes (continued)**Application/Control No.**

09/924,054

Examiner

John L. Shew

Applicant(s)/Patent under Reexamination

SAITO, HIROYUKI

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	538,540	10/19/2005	JS
709	220,221	10/14/2005	JS
	222,225		
	226,238		
	239		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner